# ٠,٠

# Notice of R ferences Cited

Application/Control No. 09/412,558	Applicant(s)/Pate Reexamination HWANG ET AL.			
Examiner	Art Unit			
S. Devi Ph D	1645	Page 1 of 1		

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-US 2003/0219459 A	11-2003	Bachmann et al.	424/199.1
	В	US-6,387,684 B1	05-2002	Hwang et al.	435/233
	С	US-6,048,527 A	04-2000	Granoff et al.	424/150.1
	D	US-6,287,568 B1	09-2001	Wang et al.	424/197.11
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			- <del> </del>

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	S					
	Т					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	McGuinnes et al. Mo. Microbiol. 7: 505-514, 1993		
	٧	Gray et al. PNAS 81: 2645-2649, 1984		
	w			
	х			

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

